

Preliminary



XTC7006H

26.0000 MHz

TCXO

Features:

- Ultra Miniature SMD Package
- Good Frequency Stability
- Good Phase Noise Response
- Moisture Sensitivity Level (MSL) : Level-1

Description and Applications:

Surface mount 2.0mmx1.6mm TCXO for use in wireless communications devices

Electrical Specifications:

LH7 +\$\$* <	Specifications				
Nominal Frequency, Fo	26.0 MHz				
Storage Temperature Range	-40°C to +85°C				
Operating Temperature Range	-40°C to +85°C				
Power Supply Voltage, Vcc	2.8 V +/-5%				
Output Waveform	Clipped Sinewave				
Output Voltage with Load 10pF//10KΩ, Vout	0.8 Vp-p min				
Power Supply Current, Icc	2.0 mA max				
Frequency Tolerance as Received Ref. to Nominal Freq	+/- 1.0 ppm max @ 25°C +/- 3°C				
Frequency Deviation after 2 x Reflow Ref. to pre-reflow Freq.	+/- 1.0 ppm max @ 25°C +/- 3°C				
Frequency Stability a. Vs. Temperature (-40~85°C) b. Vs. Load varied 10pF//10KΩ+/-10% c. Vs. Supply Voltage varied Vcc+/-5%	+/- 1.0 ppm reference to 25°C +/- 0.2 ppm +/- 0.2 ppm				
Frequency stability slope Vs. Temperature (-30~85°C)	±0.1 ppm/°C				
Hysteresis	+/- 0.6 ppm				
Start Up Time (90% of final RF level in Vp-p)	2.0 msec max.				
Aging	+/-1.0 ppm/year @25°C				
Harmonics	-8.0 dBc max				

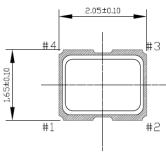


SSB Phase Noise (@1Hz Carrier Offset)	-62 dBc/Hz typ
(@10Hz Carrier Offset)	-90 dBc/Hz typ
(@100Hz Carrier Offset)	-112 dBc/Hz typ
(@1KHz Carrier Offset)	-132 dBc/Hz typ
(@10KHz Carrier Offset)	-145 dBc/Hz typ
(@100KHz Carrier Offset)	-147 dBc/Hz typ
Marking	Laser marking

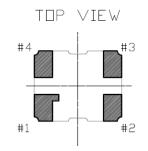
CAUTION: Electrostatic Sensitive Device. Observe precautions for handling. NOTES:

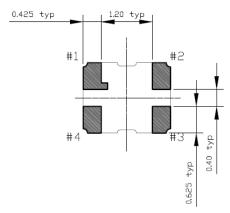
- The design, manufacturing process, and specifications of this device are subject to change.
 US or International patents may apply.
- 3. RoHS compliant from the first date of manufacture.

Mechanical Dimensions (mm):



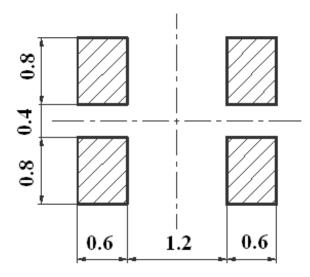






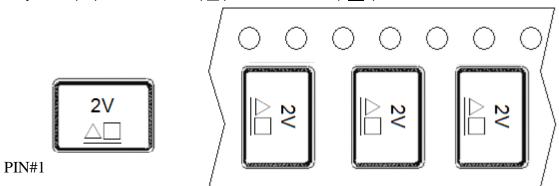
	Pin Connection
#1	GND
#2	GND
#3	Dutput
#4	+Vcc

Recommended Land Pattern: (unit: mm)



Marking:

Line 1: Letter (2V) Line 2: Symbol (.) + Year Code (\triangle) + Week Code (\square)



Year Code (Δ) :

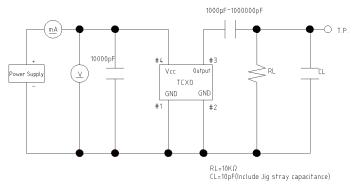
Year	2020	2021	2022	2023	2024	2025	2026	2027	2028	2029
Code	0	1	2	3	4	5	6	7	8	9

Week Code (\Box) :

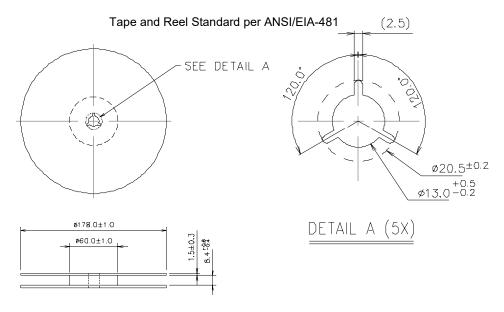
WK01	WK02	WK03	WK04	WK05	WK06	WK07	WK08	WK09	WK10	WK11	WK12	WK13
Α	В	С	D	E	F	G	Н	I	J	K	L	М
WK14	WK15	WK16	WK17	WK18	WK19	WK20	WK21	WK22	WK23	WK24	WK25	WK26
N	0	Р	Q	R	S	Т	U	V	W	Х	Y	Z
WK27	WK28	WK29	WK30	WK31	WK32	WK33	WK34	WK35	WK36	WK37	WK38	WK39
а	b	С	d	е	f	g	h	i	j	k	I	m
WK40	WK41	WK42	WK43	WK44	WK45	WK46	WK47	WK48	WK49	WK50	WK51	WK52
n	0	р	q	r	S	t	u	v	w	х	У	z

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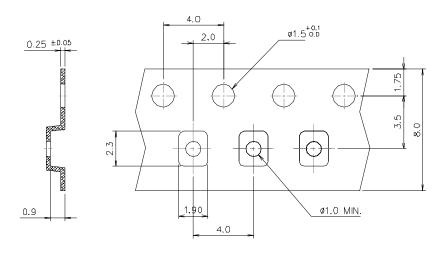
Recommended Circuit



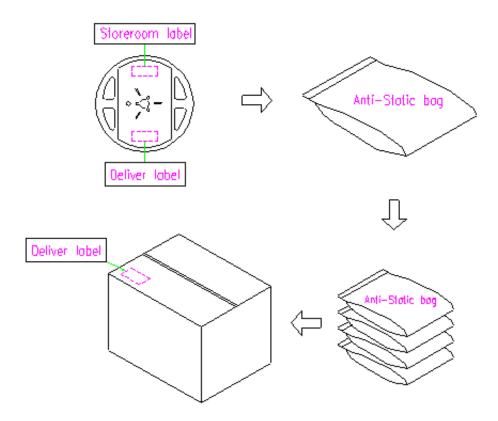
Reel Dimensions



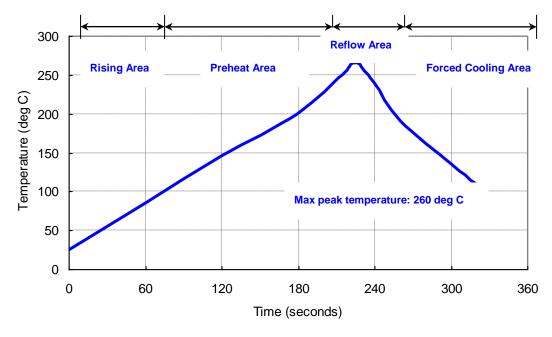
Tape Dimensions



Packing Quantity/Packing: 3K pcs maximum per reel



Reflow Profile:



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Notes of the Usage:

- 1. Touch the solder iron at 260+/-5 deg C onto the leads for 10+/-2 sec max or touch the solder at 350+/-5 deg C onto the leads for 3+/-0.5 sec.
- 2. In the customer's reflow process, if it will remain some mechanical stress at the soldering terminals, also make some cracks on the soldering termination. Some cracks will cause open or short circuit and cause of thermal increasing or smoking. Don't make any excess mechanical stress to soldering points.
- 3. In case of giving a heavy shock to the products, it may make an open or short circuit and cause of thermal increasing and smoking. To avoid heavy shock impact applying to products is strictly required.
- 4. Ultrasonic cleaning should be avoided to prevent damage to the TCXO.
- 5. Do Not Use Ultrasonic-Wave Soldering or Wave Solder with Package Immersed in Solder.
- 6. Do not lay out the ground (GND) pattern under crystal unit, this will add parasitic capacitance.
- 7. Do not run Digital / RF signal lines, power, or ground under oscillators for multi-layered PCB, as this will add noise.

Notes of the Storage:

- To keep products under the condition at the room temperature (-5~35 deg C) with normal humidity (45~75%). Absorption of moisture and dewdrop may make inferiority of characteristics and a short circuit.
- 2. Oxidization of terminals shall make the solderability more inferior. Dusts and corrosive gas will make a cause of the open or short circuit. Keep it in the clean place where is not in dusty and no corrosive gas.
- 3. Use the anti-static material to the storage package.
- 4. Don't put any excess weight to the TCXO in the storage process.
- 5. Don't move the product from the cold place to the hot place in the short time, otherwise it may make some dew-drop, then a short circuit may happen in case.
- 6. Storage periods should be maximum 6 months under condition of above item 1 after delivery from the factory.
- 7. Once open the bag, there is possibility of electrical characteristics deterioration due to absorption of moisture. So, please use parts within 7 days after opening the bag.
- 8. If you have to keep parts without using after opening the bag, please put the drying agent in the bag, fold the bag and keep it in the place where temperature and humidity are controlled (nitrogen atmosphere box etc.)

Reliability Specifications

Test name	Test process / method	Reference standard						
Mechanical characteristics								
resistance to Soldering heat (IR reflow)	Temp./ Duration : 265°C /10sec ×2 times Total time : 4min.(IR-reflow)	EIAJED-4701 -300(301)M(II)						
Vibration	Total peak amplitude : 1.5mmVibration frequency: 10 to 2000 HzSweep period: 20 minuteVibration directions: 3 mutually perpendicularDuration: 2 hr / direc.	MIL-STD 202G method 204						
Mechanical Shock	directions : 3 impacts per axis Acceleration : 3000g's, +20/-0 % Duration : 0.3 ms (total 18 shocks) Waveform : Half-sine	MIL-STD 202G method 213						
Solderability	Solder Temperature:265±5°C Duration time: 5±0.5 seconds.	J-STD-002						
Environmental	characteristics							
Thermal Shock	Heat cycle conditions -40 $^{\circ}$ (30min) \iff 85 $^{\circ}$ (30min) * cycle time : 10 times	MIL-STD 883G method 1010.8						
Humidity test	Temperature : 85 ± 2 °C Relative humidity : 85% Duration : 96 hours Temperature : 125 ± 2 °C	MIL-STD 202G method 103						
Dry heat (Aging test)	Temperature : 125 ± 2 °C Duration : 168 hours	MIL-STD 202G method 108A						
Cold resistance (Low Temp Storage)	Temperature : -40 ± 2 °C Duration : 96 hours	IEC 60068-2-1						